Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10808971	TEN EYCK ET AL.
Examiner	Art Unit
John P Lacyk	3735

SEARCHED			
Class	Subclass	Date	Examiner
600	21-22, 300-301, 523	6/10/07	JPL
705	3	6/10/07	JPL
340	573.1, 691.6	6/10/07	JPL
Updated	above	1/17/08	JPL
Updated	above	7/03/08	JPL
Updated	above	1/31/09	JPL

SEARCH NOTES		
Search Notes	Date	Examiner

	INTERFERENCE SEAF	RCH	
Class	Subclass	Date	Examiner

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